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Autore	Kazmiruk Viacheslav
Titolo	Scanning electron microscopy // Viacheslav Kazmiruk
Pubbl/distr/stampa	IntechOpen, 2012 [Place of publication not identified] : , : IntechOpen, , 2012 ©2012
ISBN	953-51-4329-8
Edizione	[1st ed.]
Descrizione fisica	1 online resource (848 pages)
Soggetti	TECHNOLOGY & ENGINEERING / Electronics / Optoelectronics
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Sommario/riassunto	<p>Today, an individual would be hard-pressed to find any science field that does not employ methods and instruments based on the use of fine focused electron and ion beams. Well instrumented and supplemented with advanced methods and techniques, SEMs provide possibilities not only of surface imaging but quantitative measurement of object topologies, local electrophysical characteristics of semiconductor structures and performing elemental analysis. Moreover, a fine focused e-beam is widely used for the creation of micro and nanostructures. The book's approach covers both theoretical and practical issues related to scanning electron microscopy. The book has 41 chapters, divided into six sections: Instrumentation, Methodology, Biology, Medicine, Material Science, Nanostructured Materials for Electronic Industry, Thin Films, Membranes, Ceramic, Geoscience, and Mineralogy. Each chapter, written by different authors, is a complete work which presupposes that readers have some background knowledge on the subject.</p>

2. Record Nr.	UNIORUON00051675
Autore	JOUON DES LONGRAIS, F.
Titolo	Age de Kamakura : Sources (1150-1333), archives : Chartes japonaises (monjo) / F. Jouon des Longrais
Pubbl/distr/stampa	Tokyo, : Maison Franco-Japonaise, 1950
Descrizione fisica	XXIII, 451 p. ; 24 cm
Classificazione	GIA IV AA
Soggetti	GIAPPONE - STORIA - PERIODO KAMAKURA (1192-1333) - FONTI
Lingua di pubblicazione	Francese
Formato	Materiale a stampa
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